

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : TBD Confirmation No.: TBD
Applicant : Randolph W. Kahn et al.
Filed : 12/4/2003
TC/A.U. : TBD
Examiner : TBD

Docket No. : TI-24186.1
Customer No. : 23494

Title : IN-SITU RANDOMIZATION AND RECORDING OF WAFER
PROCESSING ORDER AT PROCESS TOOLS

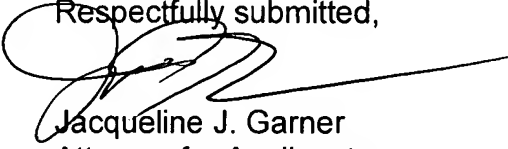
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Washington, DC 20231

Dear Sir:

Please make the references listed on the enclosed PTO-1449 of record under 37 C.F.R. 1.56, 1.97, and 1.98 in the patent application identified above. Copies of the listed references are not enclosed as per 37 C.F.R. 1.98(d). The listed references were previously submitted to, or cited by, the Patent Office in an earlier application U.S. Serial No. 09/997,930, filed 11/30/2001 which is relied on for an earlier effective filing date under 35 U.S.C. 120.

Respectfully submitted,


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				Complete If Known	
				Application Number	TBD
				Filing Date	12/4/2003
				First Named Inventor	Randolph W. Kahn
				Group Art Unit	TBD
				Examiner Name	TBD
Sheet	1	of	1	Attorney Docket No.	TI-24186.1

U.S. PATENT DOCUMENTS						
Exam. Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Doc.	Date of Pub. of Cited Doc. (mm-yyyy)	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
	AA	5,183,370		Cruz	02-1993	
	AB	5,761,065		Kittler et al.	06-1998	
	AC	6,180,424		Tigelaar et al.	01-2001	
	AD	6,213,708		Allen	04-2001	
	AE	6,336,086		Perez et al.	01-2002	
	AF	6,599,763		Reyes et al.	07-2003	
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FOREIGN PATENT DOCUMENTS								
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